

Special Issue

Computing and Artificial Intelligence for Visual Data Analysis

Message from the Guest Editors

This Special Issue aims at disseminating recent advances in theory and applications of computing and artificial intelligence. We cordially invite authors to submit papers presenting original contributions in the field of visual intelligence. This Special Issue aims to disseminate a set of high-quality works that address theory and design of computing and artificial intelligence and apply these to interesting applications (visual surveillance, autonomous driving, biomedical data analysis, etc.). We will be glad to receive papers with state-of-the-art reviews, original research, and real-world applications. Keywords

- Computing methods and algorithms
- Artificial intelligence
- Machine learning
- Computer vision
- Visual intelligence
- Autonomous driving
- Intelligent transportation systems
- Information fusion
- Intelligent systems

Guest Editors

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Deadline for manuscript submissions

closed (31 March 2021)



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About the Journal

Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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